

Payload on-ground calibration

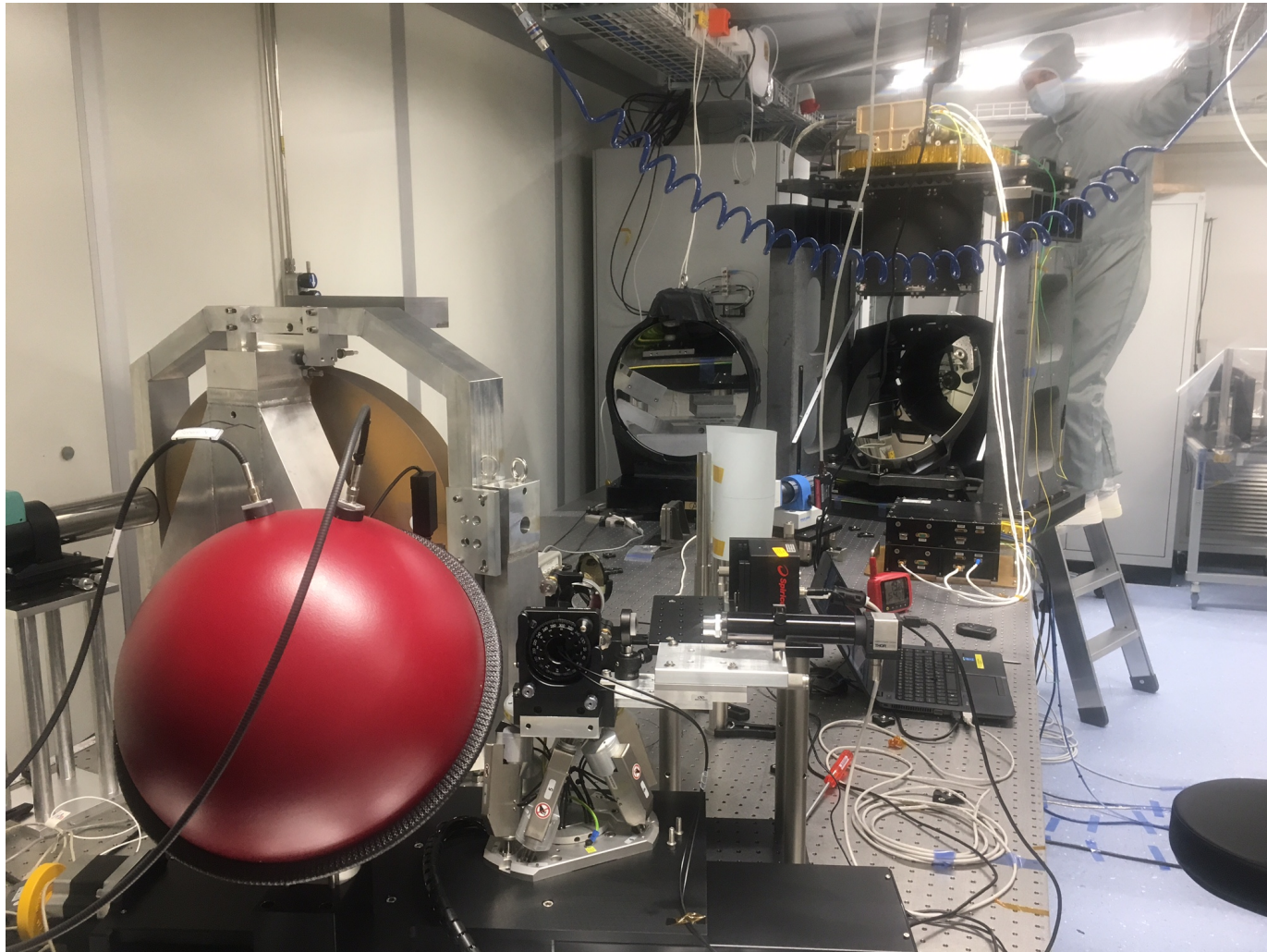
Adrien Deline
University of Geneva

Overall approach

Test campaign	Institute	Date
CCD tests	e2v	2014
CCD characterization	Geneva	2015-2016
FPM calibration	Bern	Q2-Q3 2017
Payload calibration	Geneva/Bern	Q4 2017

*FPM : Focal plane module

Calibration bench @ UNIBE



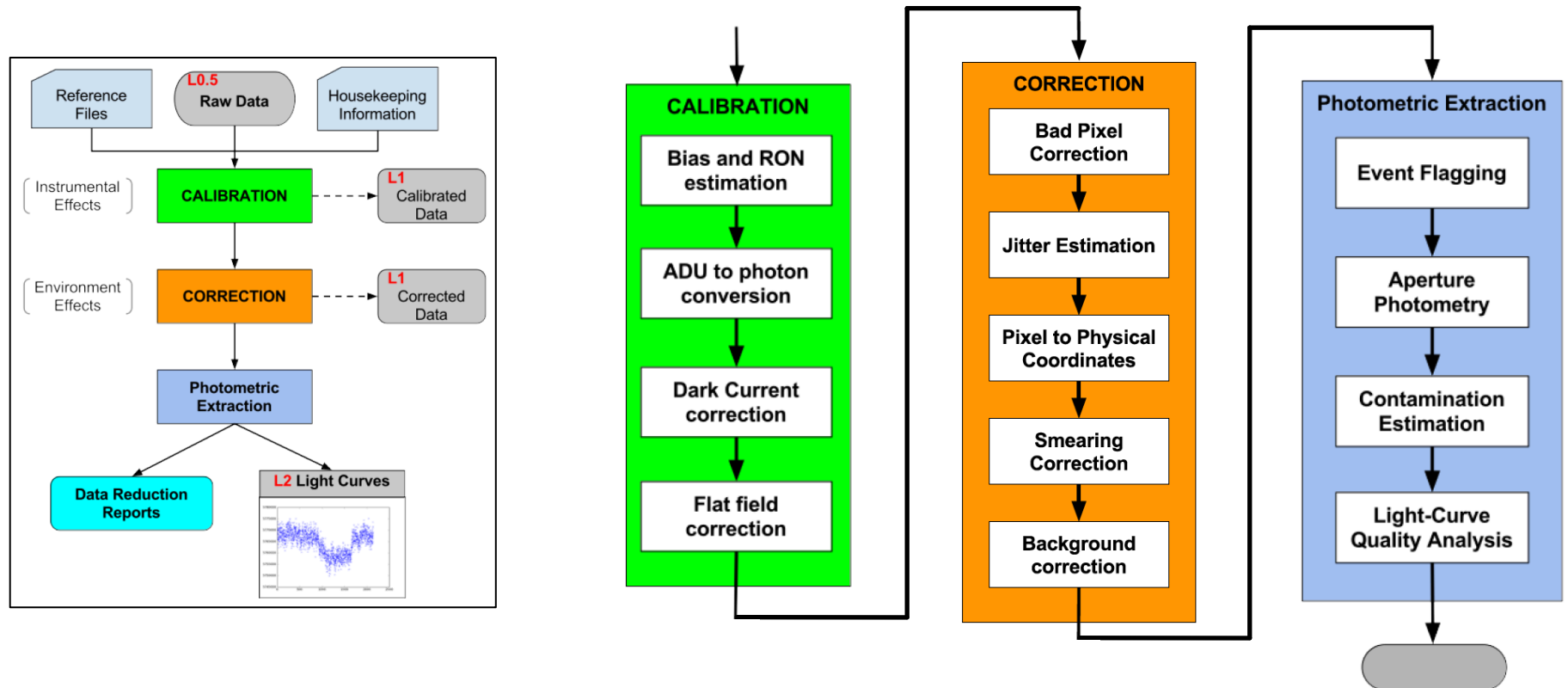
Context

- CHEOPS does not have an on-board calibration source nor a shutter
- All the key measurements already done during CCD characterization campaign
- Most of these results have to be measured again during payload calibration
 - change of electronics
 - payload optics
 - but gain sensitivities are measured for good
- Some of these results will be updated in-flight during the Monitoring & Characterization phase (M&C)

→ See R. Alonso's talk
(talk n°6.2)

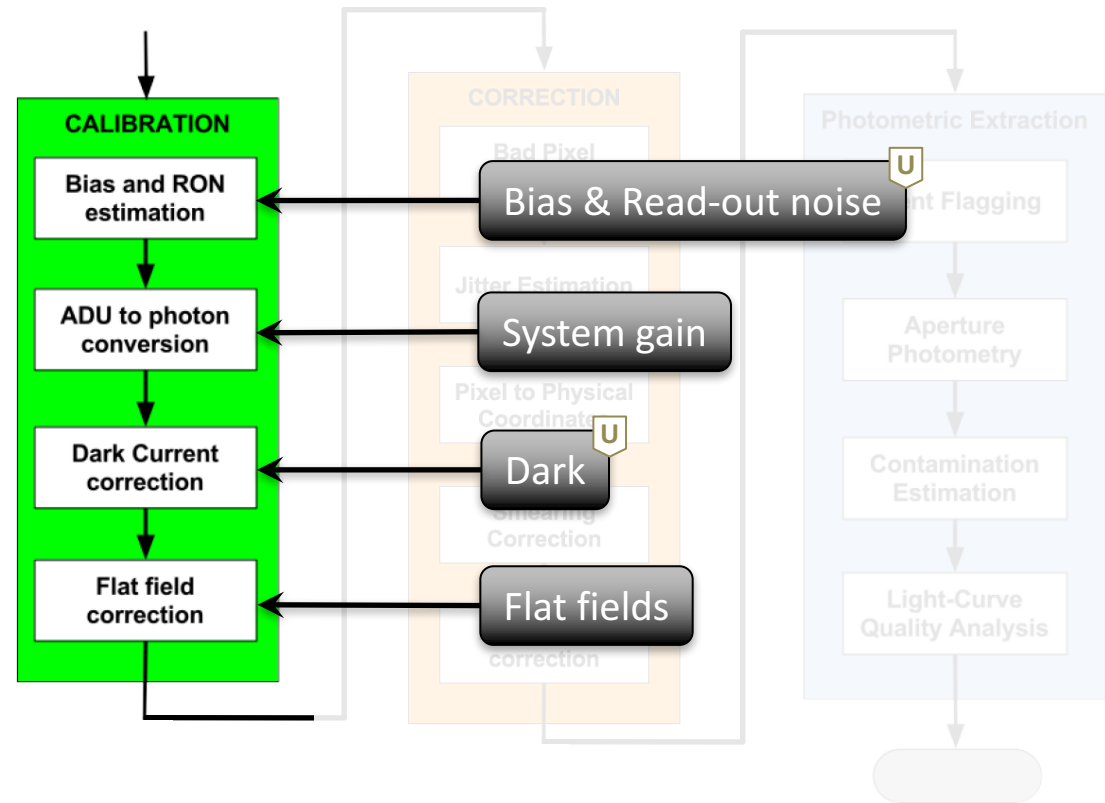
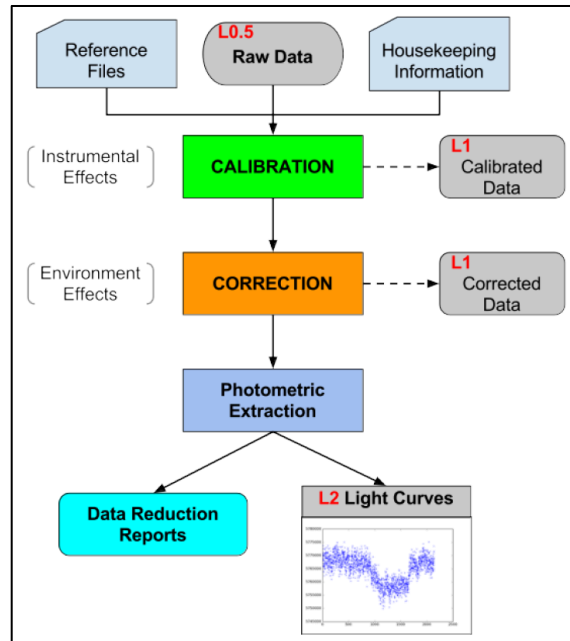


Inputs for DRP



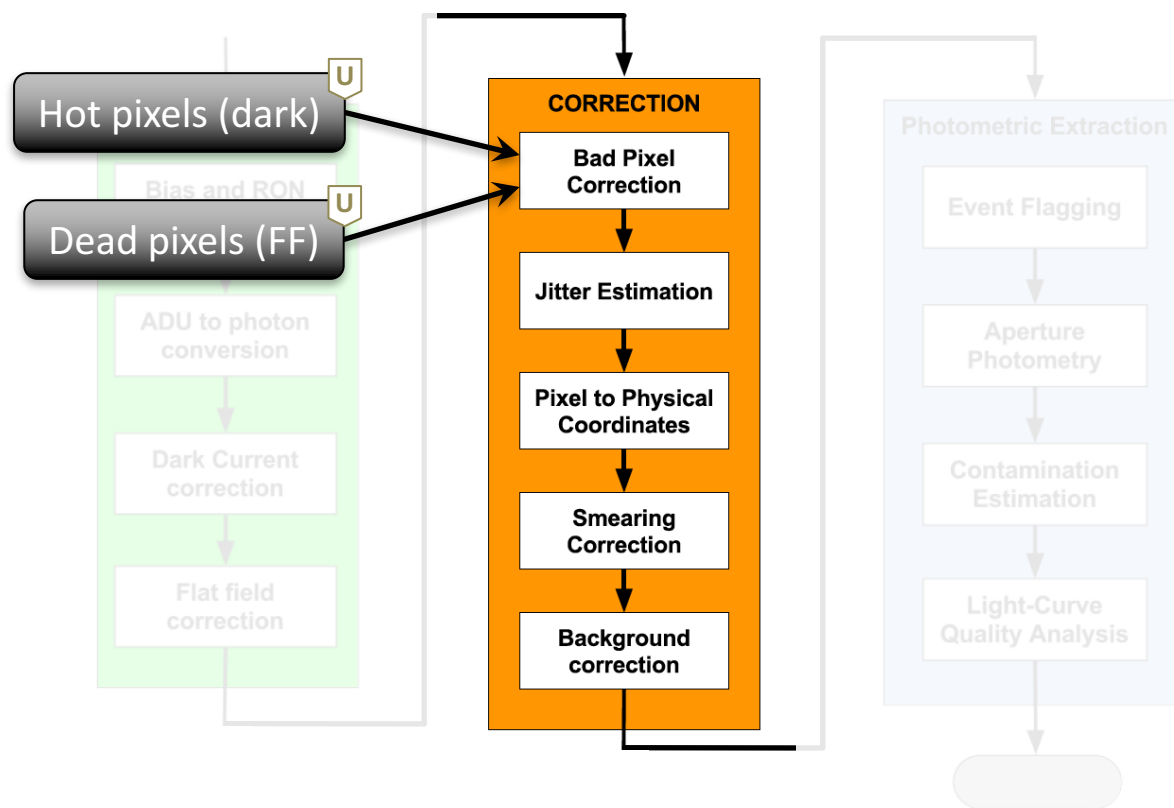
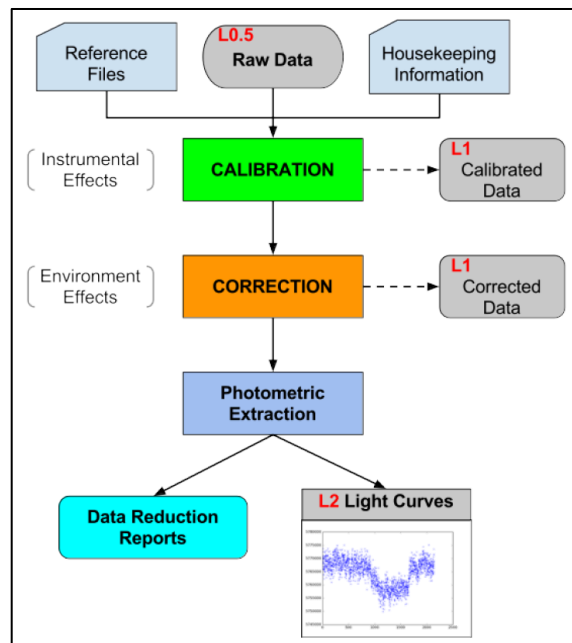
See S. Hoyer's talk
(talk n°8)

Inputs for DRP



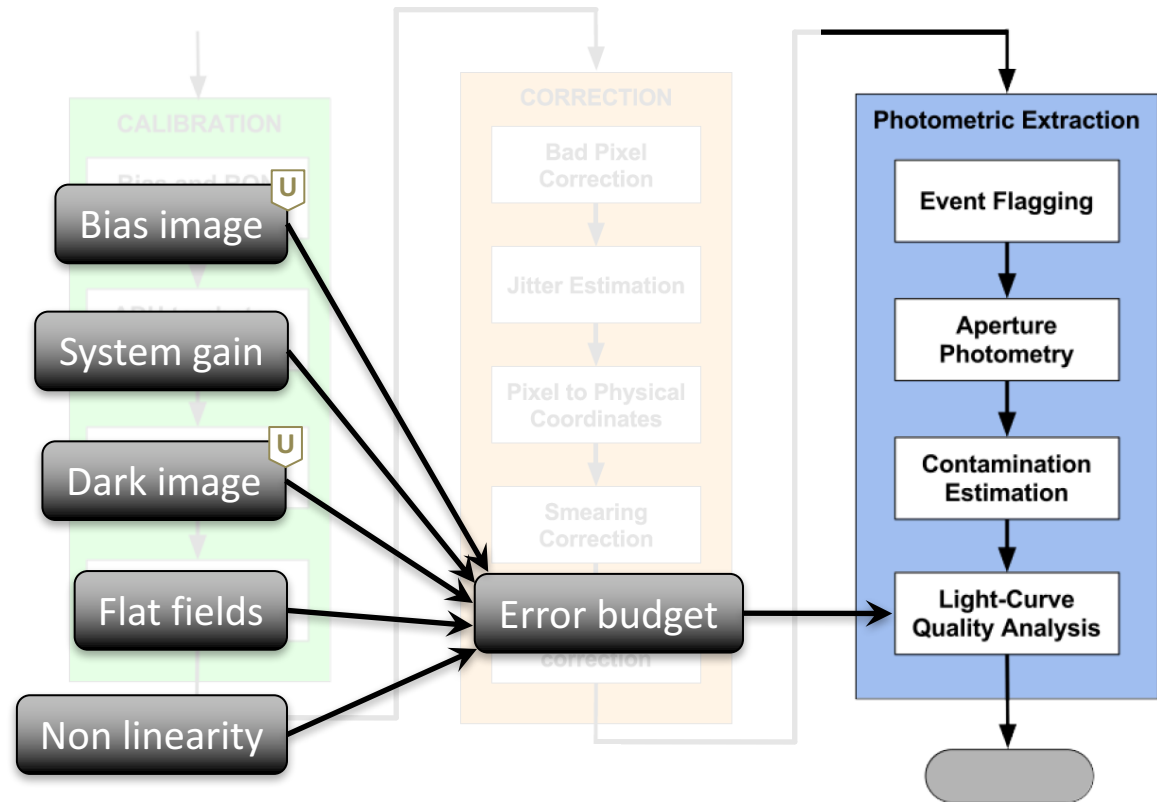
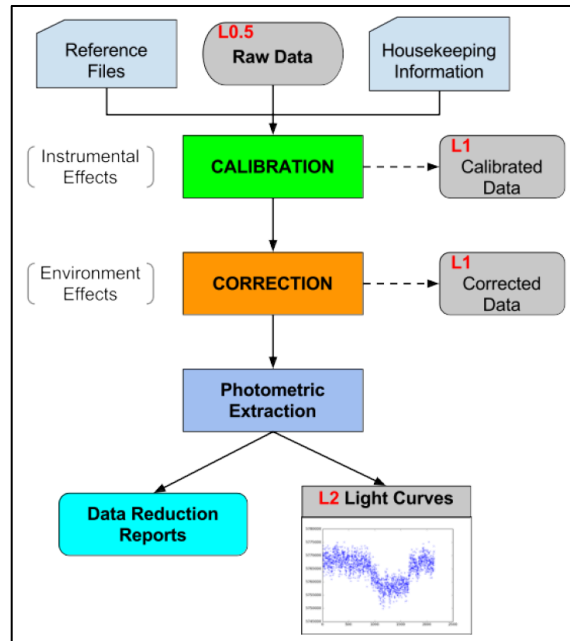
U will be updated during in-flight M&C

Inputs for DRP



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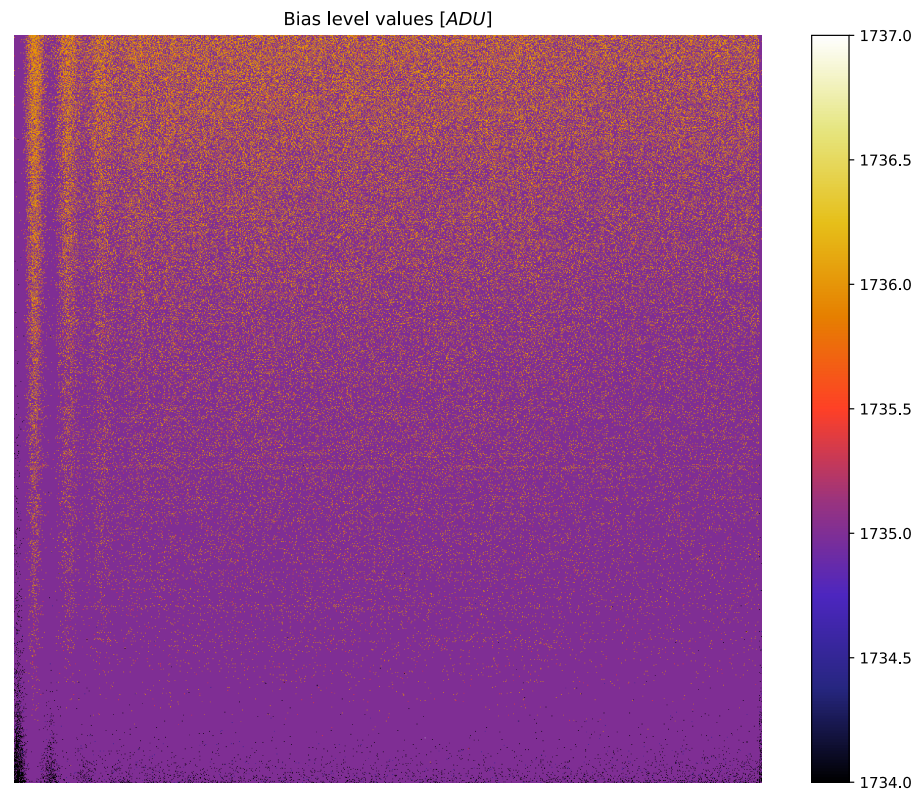
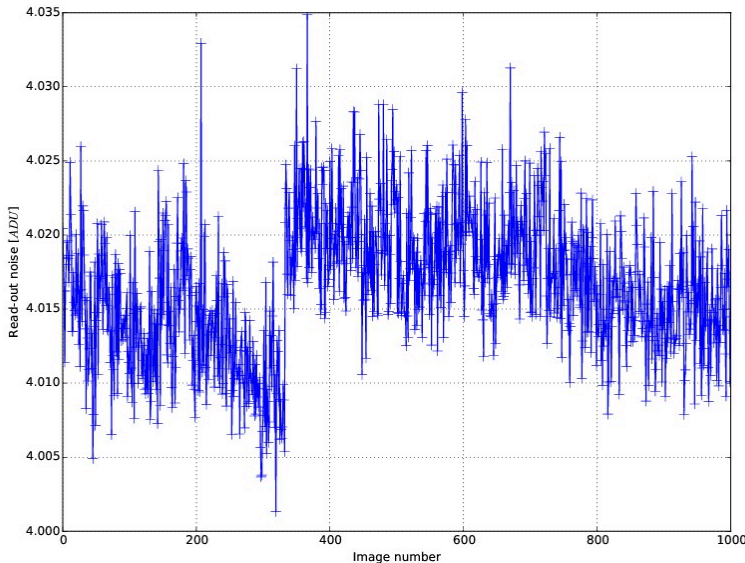
Inputs for DRP



will be updated during in-flight M&C

Bias & Read-out noise

- CCD characterization :
 - 0s exposures in the dark
 - Bias level = 1735 ± 1 ADU
 - RON = 4.02 ± 0.01 ADU

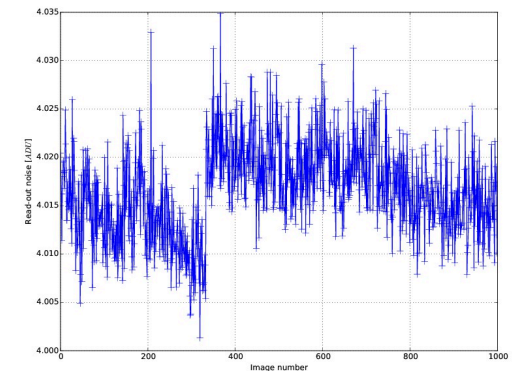
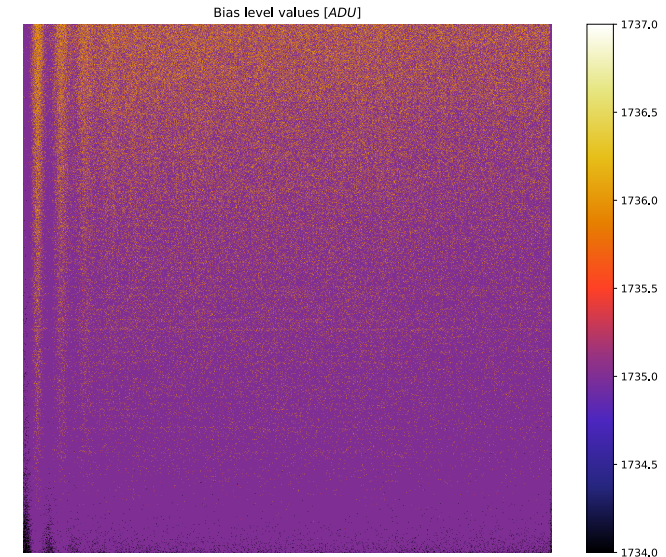


from FM2 test report
(*CHEOPS-UGE-SYS-120_1.2*)

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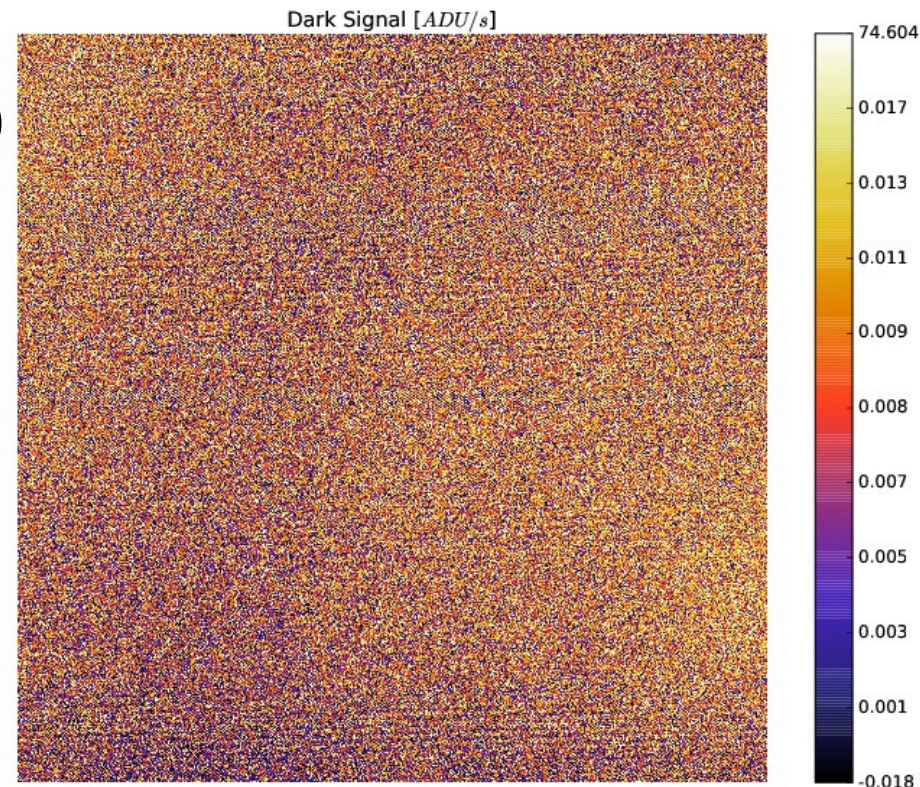
- Measurements during payload calibration
 - dependence on electronic chain
 - small RON variations with V_{bias}
(less than 0.2 ADU/V, from CCD characterization)



Dark current

- CCD characterization :
 - Various exposures in the dark at different temperature (-40..20 °C)
 - Dark @ -40°C = 0.0016 ADU/s (10 times better than specs)
 - Hot pixels coordinates

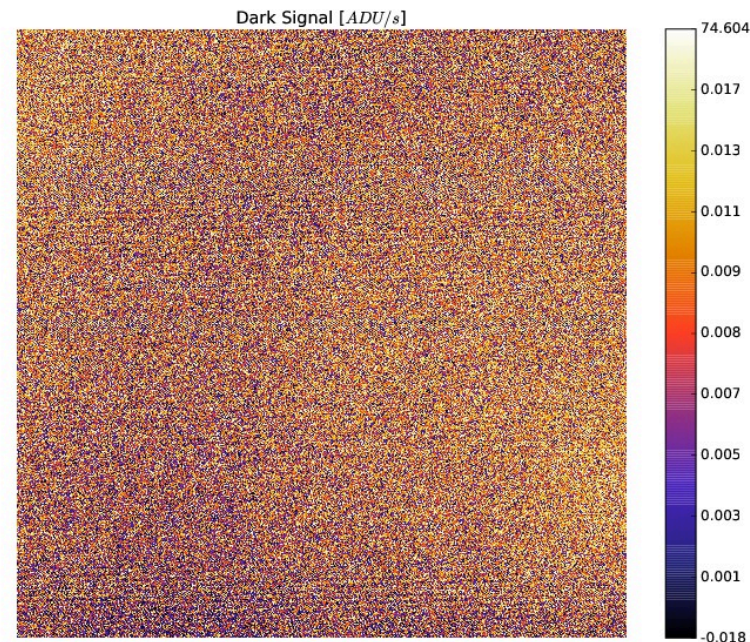
from FM2 test report
(CHEOPS-UGE-SYS-120_1.2)



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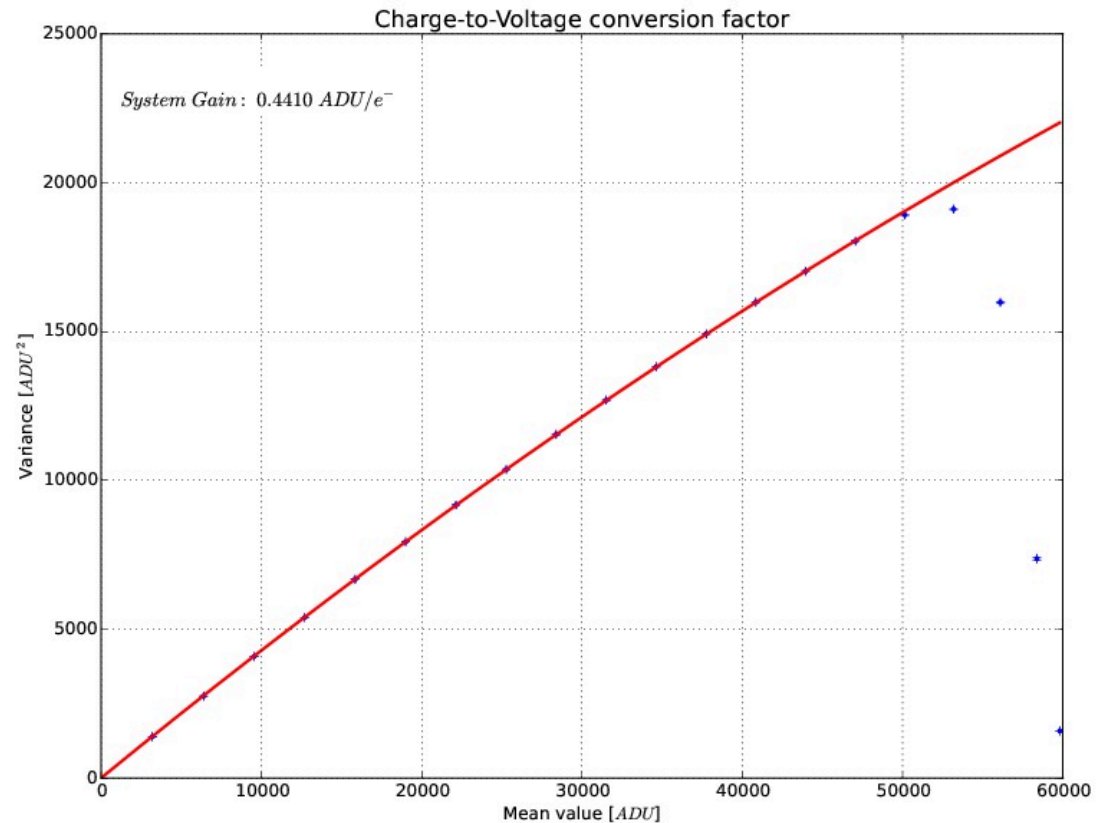
- Measurements during payload calibration
 - only at 0°C and 10°C to identify/locate hot pixels



System gain

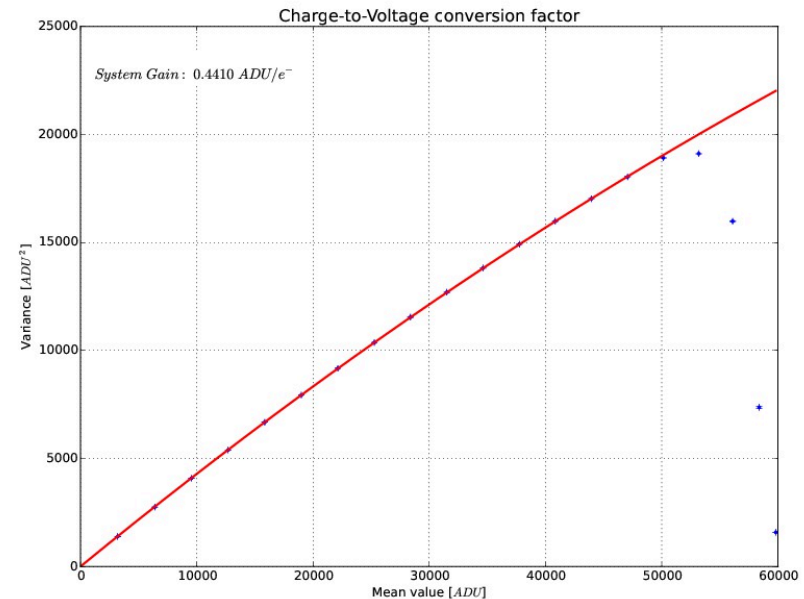
- CCD characterization :
 - Different exposures in white light up to saturation
 - Slope at (0,0) of a 2D-polynomial fit
 - Gain = 0.4410 ADU/e⁻

from FM2 test report
(CHEOPS-UGE-SYS-120_1.2)



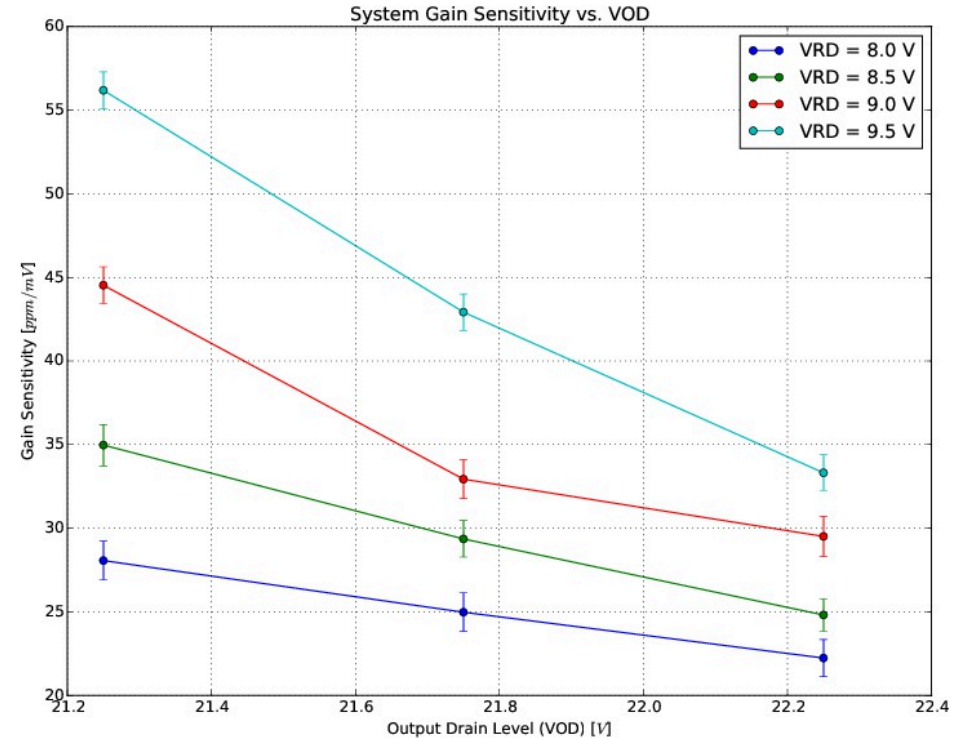
System gain

- CCD characterization :
 - Different exposures in white light up to saturation
 - Slope at (0,0) of a 2D-polynomial fit
 - Gain = 0.4410 ADU/e⁻
- Measurements during payload calibration
 - dependence on electronic chain
 - gain variations with respect to V_{bias} will be extrapolated from CCD characterization measurements



System gain

- Gain sensitivity from CCD characterization (not repeated during payload calibration campaign)



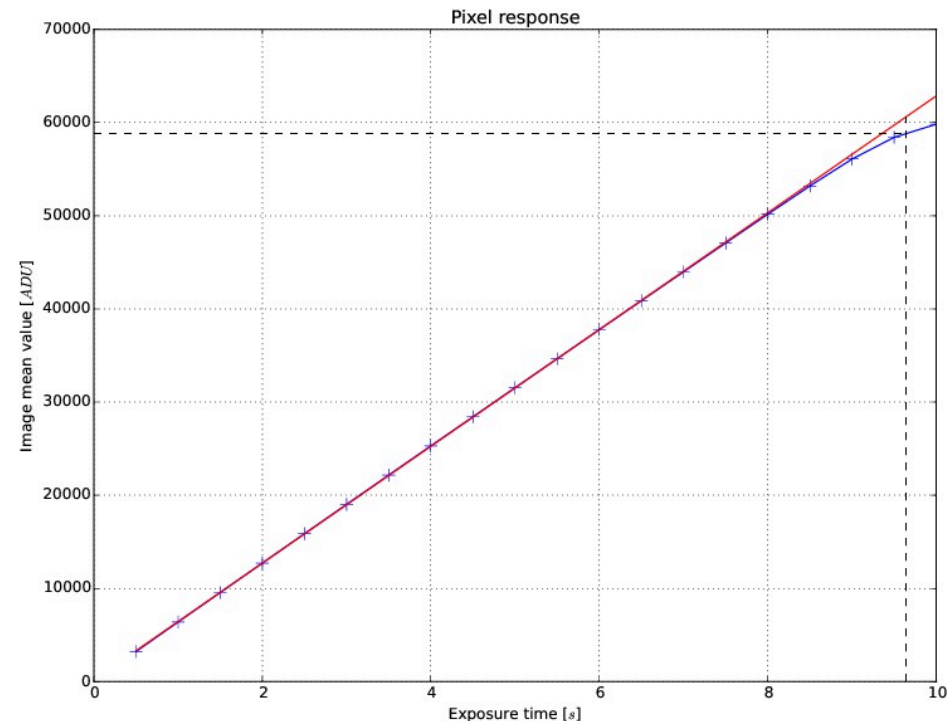
- Voltages stability from DLR (nov. 2016)
 - Very high V_{bias} stability (less than 1 mV over tens of hours)

from FM2 test report
(CHEOPS-UGE-SYS-120_1.2)

Full-well capacity

- CCD characterization :
 - Different exposures in white light up to saturation
 - Full-well capacity is defined as the point where CCD response is 3% away from linear fit
 - FWC = 58823 ADU
- Conservative definition
 - when reaching FWC, the CCD is not fully saturated (still signal beyond FW)

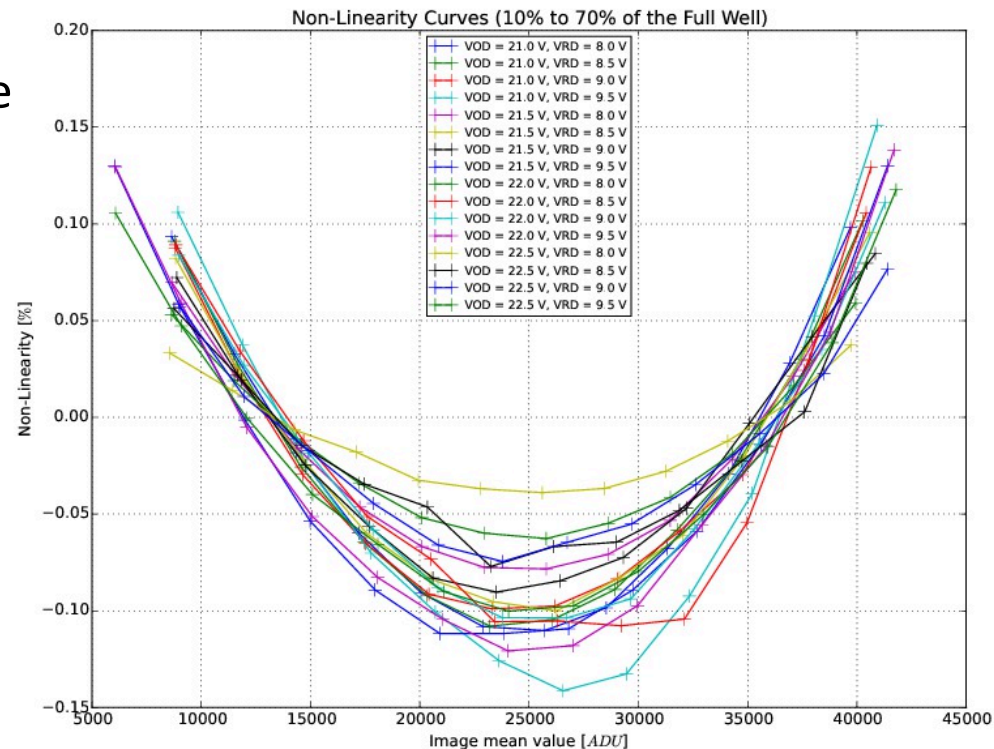
from FM2 test report
(CHEOPS-UGE-SYS-120_1.2)



Non-linearity

- CCD characterization :
 - Different exposures in white light up to saturation
 - Non-linearity is the difference between CCD response and a linear fit
 - Nominal non-lin. $\leq 0.088\%$ in the 10-to-70%_{FWC} range

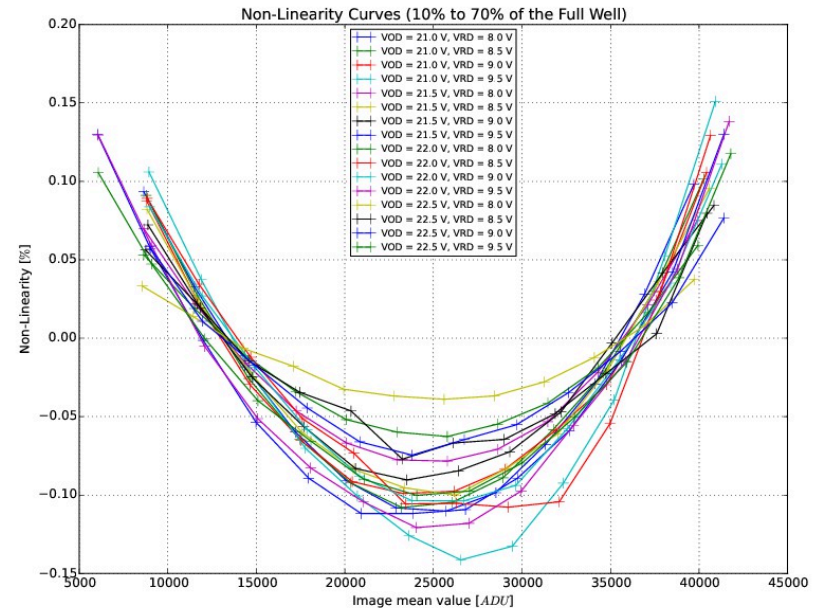
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- Measurements during payload calibration
 - should show no dependence on electronic chain (dominated by CCD)
 - nominal case only (expect very small V_{bias} variations during mission compared to the range explored)

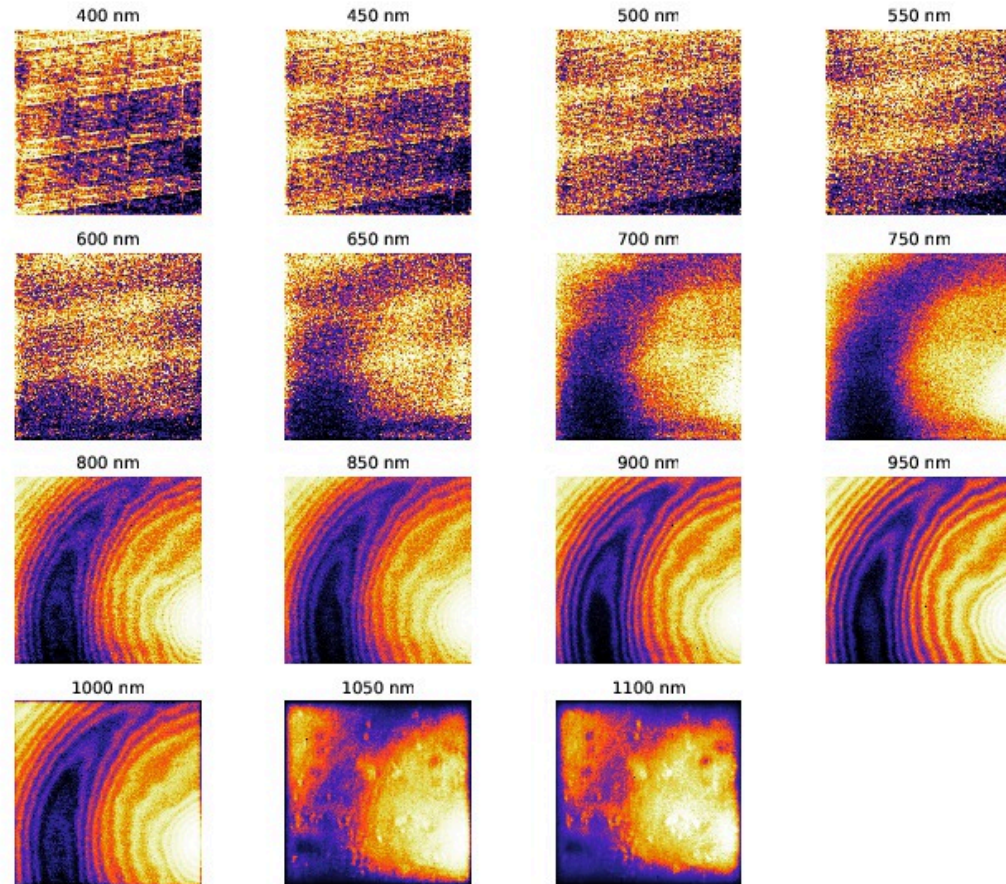


Flat fields

- CCD characterization :
 - Various exposures in monochromatic light at different λ
 - Wavelength bands of 30 nm
 - Blue diamond and “tree-ring” effects

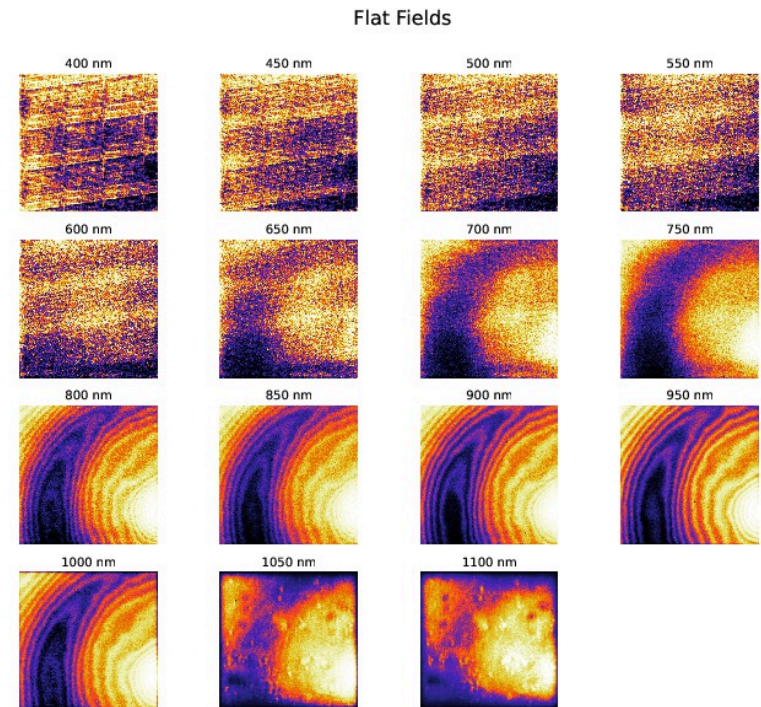
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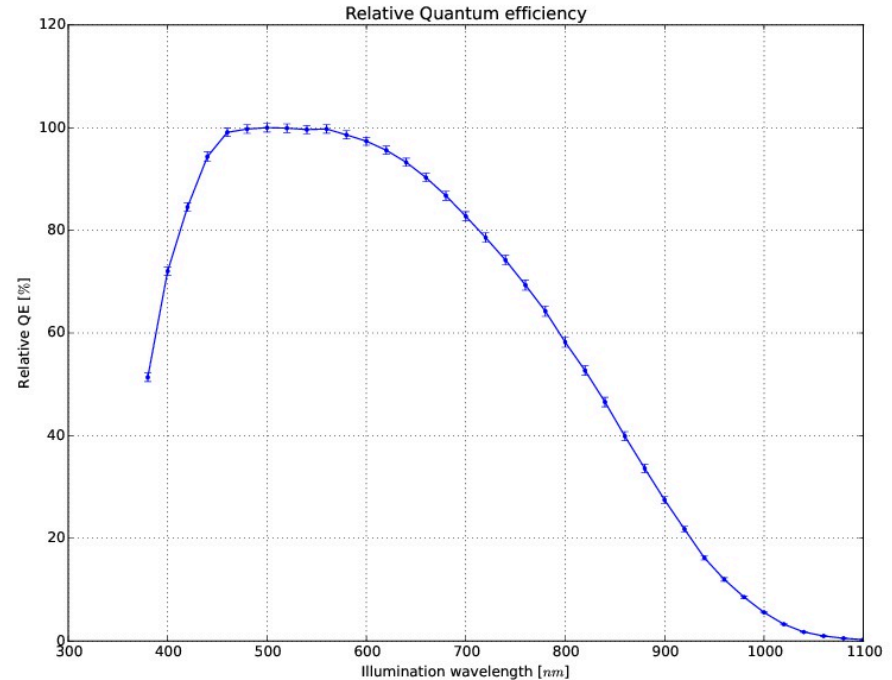
- Measurements during payload calibration
 - additional vignetting due to optics
 - denser wavelength sampling (FF combination)

Quantum efficiency

- CCD characterization :
 - Various exposures in monochromatic light at different λ
 - Wavelength bands of 30 nm

$$QE = \frac{N_{electrons}}{N_{photons}}$$

← from CCD
 ← from reference photodiode



from FM2 test report
(CHEOPS-UGE-SYS-120_1.2)

- Measurements during payload calibration
 - to include transmission of the whole optical system

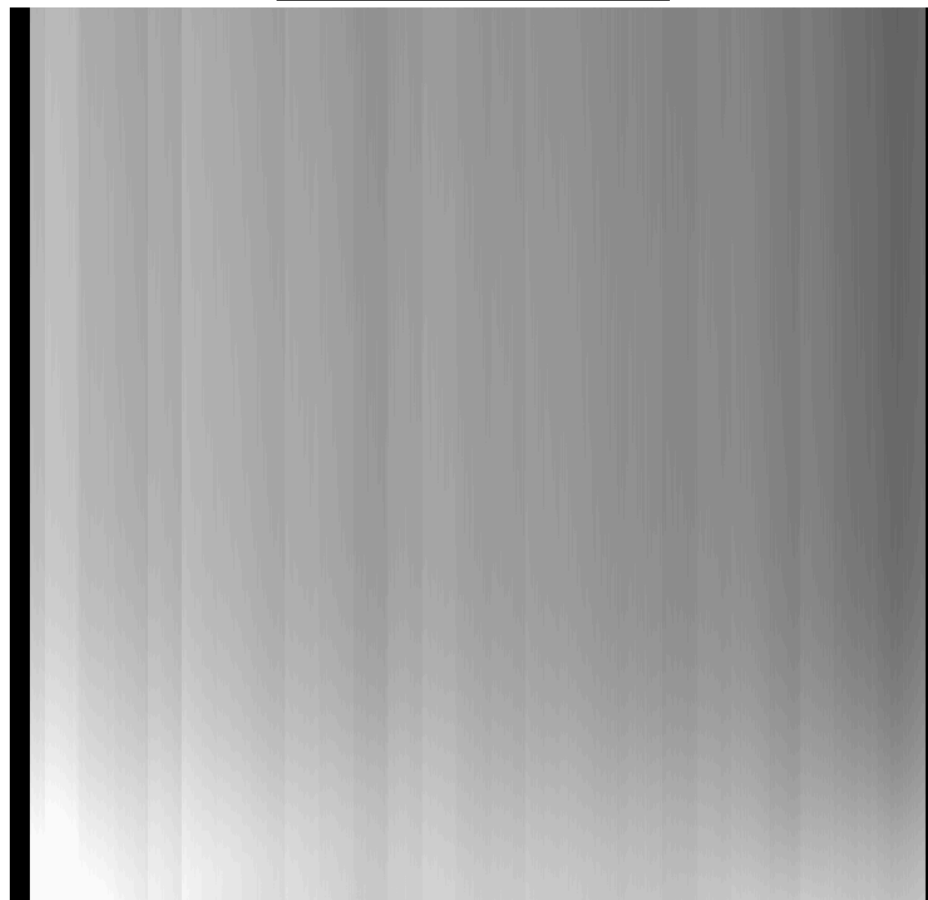


Other tests of the CCD characterization

FM1 saturation data

- Saturation
 - No memory effect

(No new measurement
planned during calibration)



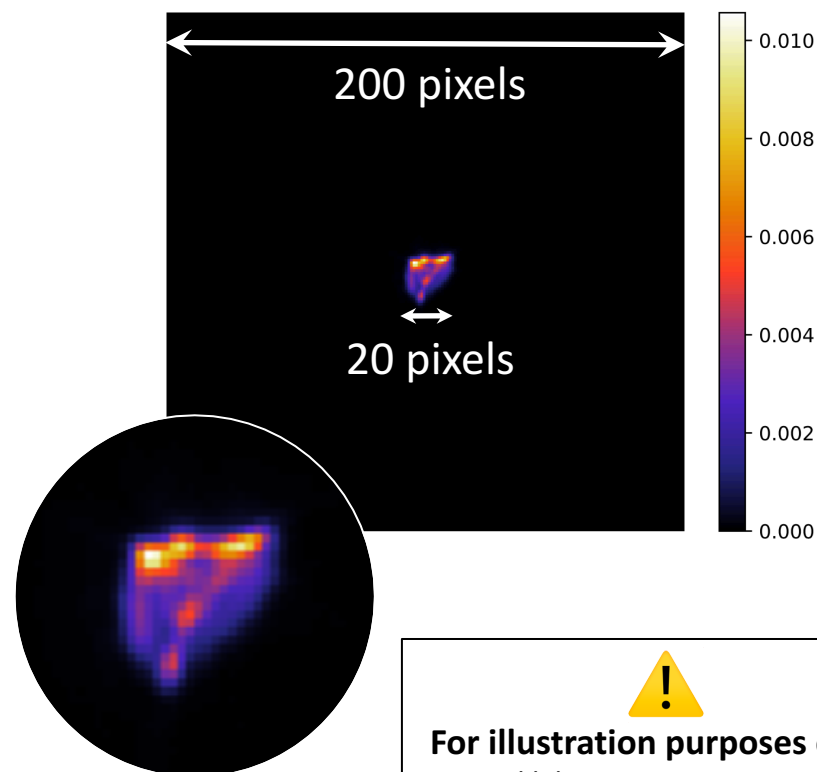
Other tests


during payload calibration campaign

PSF shape

- Functional test
 - check alignment and any optical issue
 - identify PSF for tracking
 - over FoV and λ

- No delivery of in-flight PSF
 - non-uniform illumination of the pupil
 - gravity effect




For illustration purposes only !
 Final lab PSF not yet measured.
 In-flight PSF expected to be different.

Other tests

during payload calibration campaign

Photometric performances

- This is not a calibration
- Performance test 1 : stability
 - nothing moves + tracking loop
 - stability measurement
- Performance test 2 : flat field
 - with jitter
- Performance test 3 : full
 - with temperature variations (survival heaters)

Payload on-ground calibration

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